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FORM PTO-1449

U.S. DEPARTMENT OF COMMERCE
PATENT AND TRADEMARK OFFICEATTY. DOCKET NO.
174/266APPLICATION NO.
10/756,949APPLICANTS
Ted Kwasniewski et al.CONFIRMATION NO.
Not yet assignedFILING DATE
January 13, 2004GROUP ART UNIT
~~Not yet assigned~~INFORMATION DISCLOSURE
STATEMENT BY APPLICANTS

2816

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
DL	3,633,120	01/04/72	Battjes	330	30R	/
	4,723,110	02/02/88	Voorman	330	252	/
	5,420,538	05/30/95	Brown	330	252	/
	6,236,231	05/22/01	Nguyen et al.	326	39	/
AV	6,650,140	11/18/03	Lee et al.	326	39	/

U.S. PATENT APPLICATIONS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
DL	10/317,262	/	Venkata et al.	/	/	12/10/02
	10/317,264	/	Venkata et al.	/	/	12/10/02
	10/349,541	/	Venkata et al.	/	/	01/21/03
	2003/0052709 A1	03/20/03	Venkata et al.	326	37	
	10/454,626	/	Lui et al.	/	/	06/03/03
	10/640,824	/	Wang et al.	/	/	08/13/03
	10/640,825	/	Wang et al.	/	/	08/13/03
	10/702,195	/	Baig et al.	/	/	11/04/03
	10/702,196	/	Bereza et al.	/	/	11/04/03
AV	10/757,182	/	Baig et al.	/	/	01/13/04

FOREIGN PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION	
						YES	NO

EXAMINER

DATE CONSIDERED

8/5/08

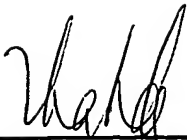
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	APPLICANTS Ted Kwasniewski et al.	CONFIRMATION NO. Not yet assigned
	FILING DATE January 13, 2004	GROUP ART UNIT Not yet assigned

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)

EXAMINER INITIAL	
PL	B. Gilbert, "The Multi-Tanh Principle: A Tutorial Overview", IEEE Journal of Solid-State Circuits, Vol. 33, No. 1, January 1998.

EXAMINER



DATE CONSIDERED

8/5/06

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